

Search Notes

Application/Control No.

10/674,616

Examiner

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Applicant(s)/Patent under
Reexamination

YOUN, JEONGNAM

Art Unit

2193

SEARCHED

Class	Subclass	Date	Examiner
708	402	7/5/2006	MAI

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor search Double Patenting Check Data Bases Search (see search history printout)	7/5/2006	MAI